

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10736690	ARELLANO ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Parker, Brandon	2174	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
715	863	10/26/2007	BP
715	530	10/26/2007	BP
715	764	10/26/2007	BP
715	762	10/26/2007	BP

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Searched IEEE and ACM	10/26/2007	BP
Updated EAST Search	05/07/2008	BP
Updated EAST Search	12/08/2008	BP

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>